

SN74ALVCH16832

1-TO-4 ADDRESS REGISTER/DRIVER WITH 3-STATE OUTPUTS

SCES098A – MAY 1997 – REVISED JULY 1997

- Member of the Texas Instruments *Widebus™* Family
- *EPIC™* (Enhanced-Performance Implanted CMOS) Submicron Process
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Packaged in Thin Shrink Small-Outline Package

description

This 1-bit to 4-bit address register/driver is designed for 2.3-V to 3.6-V V_{CC} operation. This device is ideal for use in applications where a single address bus is driving four separate memory locations. The SN74ALVCH16832 can be used as a buffer or a register, depending on the logic level of the select (\overline{SEL}) input.

When \overline{SEL} is a logic high, the device is in the buffer mode. The outputs follow the inputs and are controlled by the two output-enable (\overline{OE}) controls. Each \overline{OE} controls two groups of seven outputs.

When \overline{SEL} is a logic low, the device is in the register mode. The register is an edge-triggered D-type flip-flop. On the positive transition of the clock (CLK) input, data at the A inputs is stored in the internal registers. \overline{OE} controls operate the same as in the buffer mode.

When \overline{OE} is a logic low, the outputs are in a normal logic state (high or low logic level). When \overline{OE} is a logic high, the outputs are in the high-impedance state.

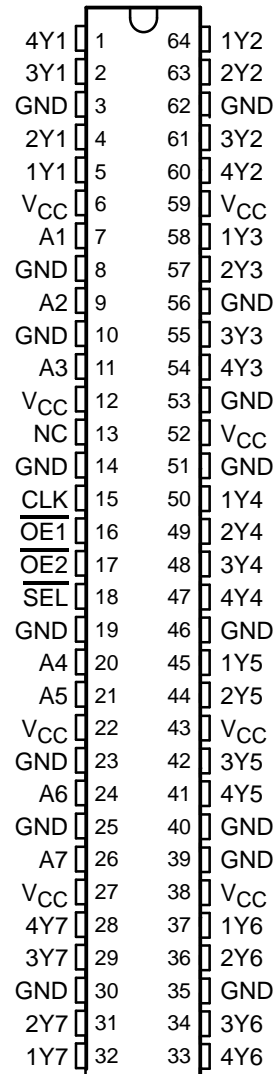
Neither \overline{SEL} nor \overline{OE} affect the internal operation of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH16832 is characterized for operation from -40°C to 85°C .

DGG PACKAGE
(TOP VIEW)



NC – No internal connection



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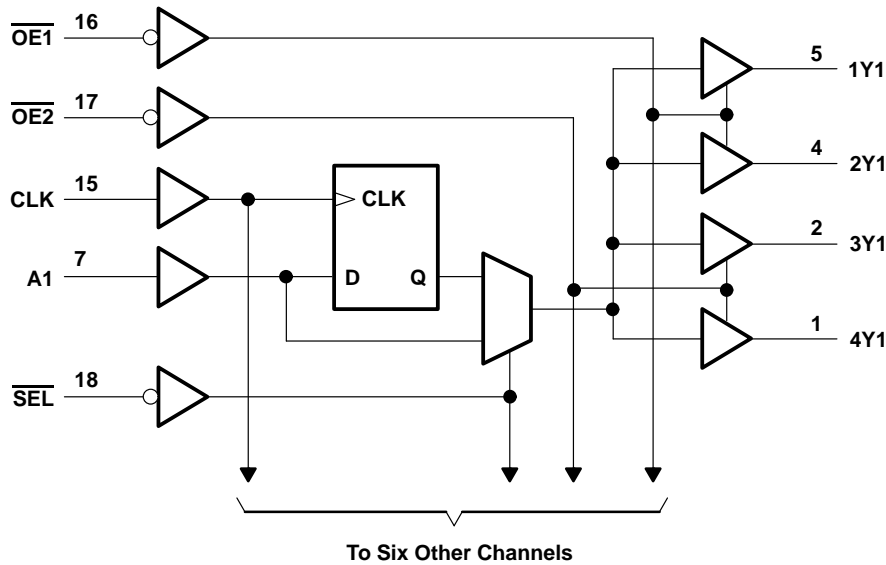
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FUNCTION TABLE

INPUTS				OUTPUT
\overline{OE}	\overline{SEL}	CLK	A	Y
H	X	X	X	Z
L	H	X	L	L
L	H	X	H	H
L	L	↑	L	L
L	L	↑	H	H

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	-0.5 V to 4.6 V
Input voltage range, V_I (see Note 1)	-0.5 V to 4.6 V
Output voltage range, V_O (see Notes 1 and 2)	-0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$)	-50 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through each V_{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 3)	73°C/W
Storage temperature range, T_{stg}	-65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 2. This value is limited to 4.6 V maximum.
 3. The package thermal impedance is calculated in accordance with JESD 51.



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recommended operating conditions (see Note 4)

		MIN	MAX	UNIT
V _{CC}	Supply voltage	2.3	3.6	V
V _{IH}	High-level input voltage	V _{CC} = 2.3 V to 2.7 V	1.7	V
		V _{CC} = 2.7 V to 3.6 V	2	
V _{IL}	Low-level input voltage	V _{CC} = 2.3 V to 2.7 V	0.7	V
		V _{CC} = 2.7 V to 3.6 V	0.8	
V _I	Input voltage	0	V _{CC}	V
V _O	Output voltage	0	V _{CC}	V
I _{OH}	High-level output current	V _{CC} = 2.3 V	-12	mA
		V _{CC} = 2.7 V	-12	
		V _{CC} = 3 V	-24	
I _{OL}	Low-level output current	V _{CC} = 2.3 V	12	mA
		V _{CC} = 2.7 V	12	
		V _{CC} = 3 V	24	
Δt/Δv	Input transition rise or fall rate	0	10	ns/V
T _A	Operating free-air temperature	-40	85	°C

NOTE 4: Unused control inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP†	MAX	UNIT	
V _{OH}	I _{OH} = -100 μA	2.3 V to 3.6 V	V _{CC} -0.2			V	
	I _{OH} = -6 mA, V _{IH} = 1.7 V	2.3 V	2				
	I _{OH} = -12 mA	V _{IH} = 1.7 V	2.3 V	1.7			
		V _{IH} = 2 V	2.7 V	2.2			
	I _{OH} = -24 mA, V _{IH} = 2 V	3 V	2.4				
V _{OL}	I _{OL} = 100 μA	2.3 V to 3.6 V			0.2	V	
	I _{OL} = 6 mA, V _{IL} = 0.7 V	2.3 V			0.4		
	I _{OL} = 12 mA	V _{IL} = 0.7 V	2.3 V				0.7
		V _{IL} = 0.8 V	2.7 V				0.4
I _{OL} = 24 mA, V _{IL} = 0.8 V	3 V			0.55			
I _I	V _I = V _{CC} or GND	3.6 V			±5	μA	
I _I (hold)	V _I = 0.7 V	2.3 V	45			μA	
	V _I = 1.7 V	2.3 V	-45				
	V _I = 0.8 V	3 V	75				
	V _I = 2 V	3 V	-75				
	V _I = 0 to 3.6 V‡	3.6 V			±500		
I _{OZ}	V _O = V _{CC} or GND	3.6 V			±10	μA	
I _{CC}	V _I = V _{CC} or GND, I _O = 0	3.6 V			40	μA	
ΔI _{CC}	One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND	3 V to 3.6 V			750	μA	
C _i	Control inputs	V _I = V _{CC} or GND	3.3 V		4.5	pF	
	Data inputs				5		
C _o	Outputs	V _O = V _{CC} or GND	3.3 V		7.5	pF	

† All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

‡ This is the bus-hold maximum dynamic current required to switch the input from one state to another.



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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

		V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
f _{clock}	Clock frequency	0	150	0	150	0	150	MHz
t _w	Pulse duration, CLK high or low	3.3		3.3		3.3		ns
t _{su}	Setup time, A data before CLK↑	2		2		1.6		ns
t _h	Hold time, A data after CLK↑	0.7		0.5		1.1		ns

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
f _{max}			150		150		150		MHz
t _{pd}	A	Y	1.7	4.6	4.1		1.6	3.6	ns
	CLK		1.6	5.1	4.4		1.5	3.9	
	SEL		1.8	5.8	5.2		1.7	4.4	
t _{en}	OE	Y	1.2	5.6	5		1.2	4.3	ns
t _{dis}	OE	Y	2.1	5.7	4.7		1.6	4.5	ns

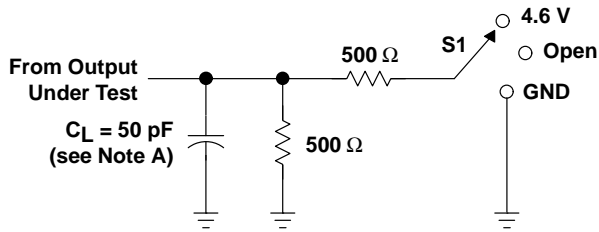
operating characteristics, T_A = 25°C

PARAMETER		TEST CONDITIONS	V _{CC} = 2.5 V ± 0.2 V	V _{CC} = 3.3 V ± 0.3 V	UNIT
			TYP	TYP	
C _{pd}	Power dissipation capacitance	C _L = 0, f = 10 MHz	119	132	pF
			Outputs enabled	22	
		Outputs disabled			



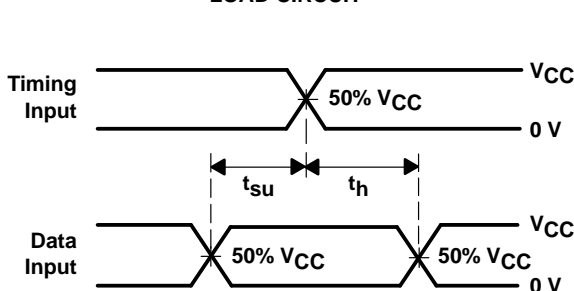
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$

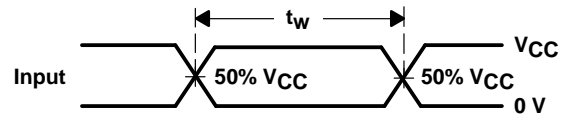


LOAD CIRCUIT

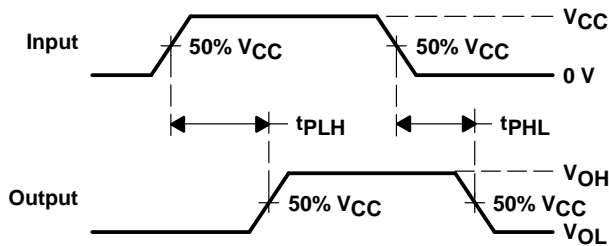
TEST	S1
t_{pd}	Open
t_{PLZ}/t_{PZL}	4.6 V
t_{PHZ}/t_{PZH}	GND



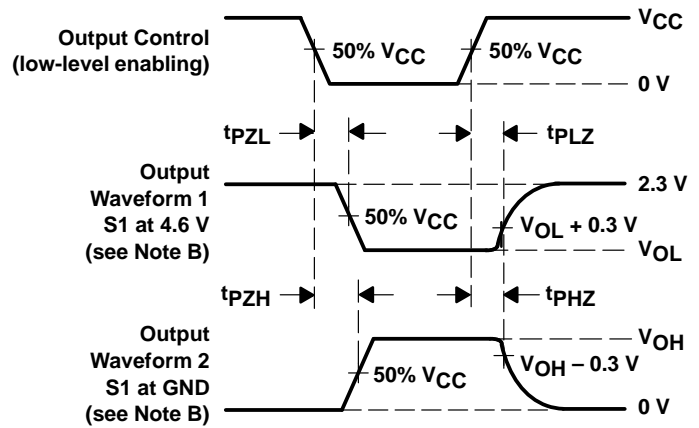
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PULSE DURATION



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES

- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 2.5\text{ ns}$, $t_f \leq 2.5\text{ ns}$.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

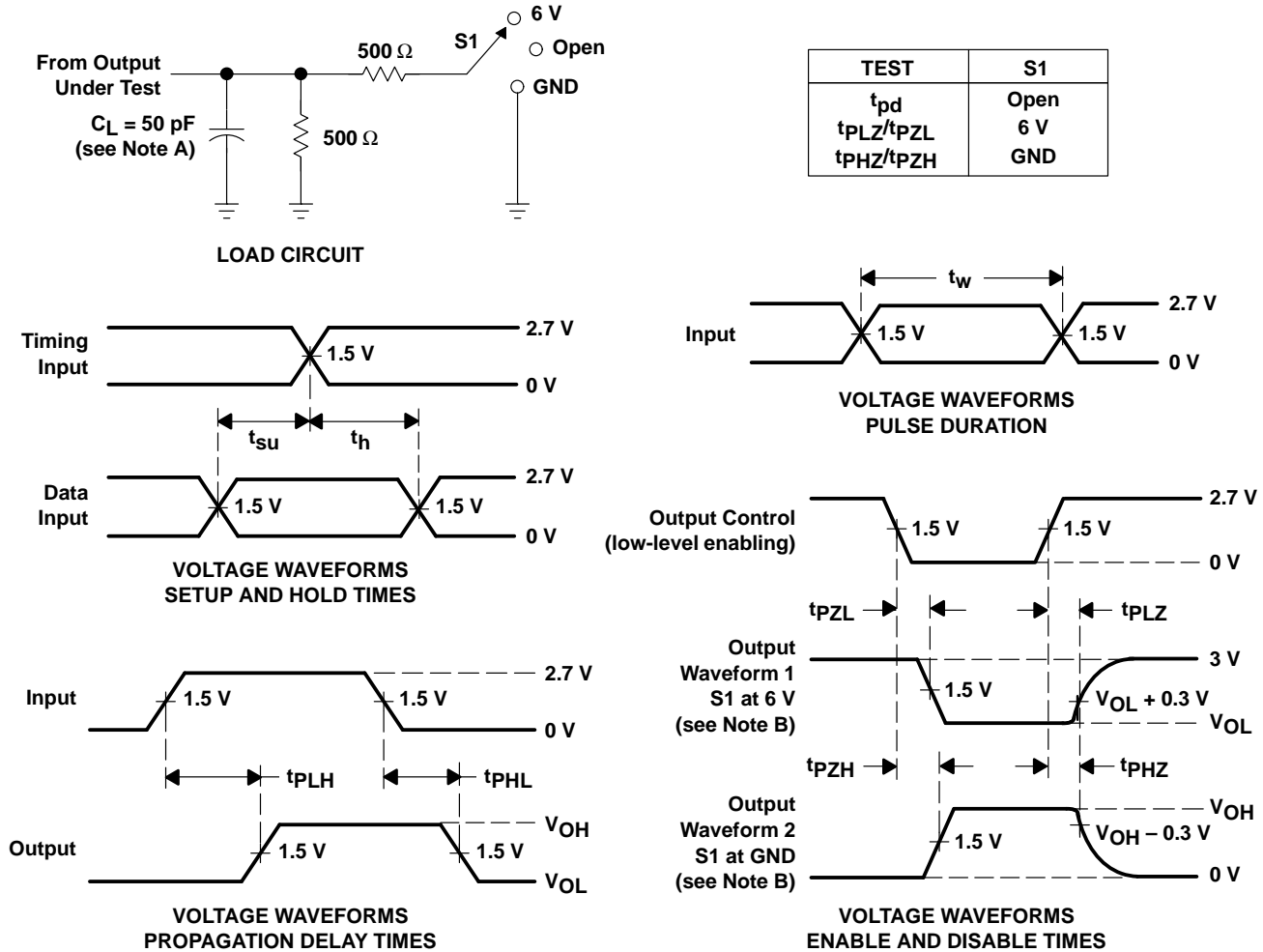
Figure 1. Load Circuit and Voltage Waveforms

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PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.7\text{ V AND } 3.3\text{ V} \pm 0.3\text{ V}$



- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 2.5\text{ ns}$, $t_f \leq 2.5\text{ ns}$.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 2. Load Circuit and Voltage Waveforms

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